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- **Qualified for Automotive Applications**
- **ESD Protection Exceeds 1500 V Per** MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Wide Operating Voltage Range of 2 V to 6 V
- **Outputs Can Drive Up To 10 LSTTL Loads**
- Low Power Consumption, 80-µA Max I<sub>CC</sub>
- Typical  $t_{pd} = 13 \text{ ns}$
- ±4-mA Output Drive at 5 V
- Low Input Current of 1 µA Max
- **Complementary Outputs**
- **Direct Overriding Load (Data) Inputs**
- **Gated Clock Inputs**
- Parallel-to-Serial Data Conversion

#### D OR PW PACKAGE (TOP VIEW) 16 V<sub>CC</sub> SH/LD CLK [ 15 CLK INH E **∏** 3 14 D F **∏** 4 13**∏** C 12 B G 🛮 5 11 🛮 A Н 10 SER $\overline{Q}_H []7$ 9 🛮 Q<sub>H</sub> GND 8

#### description/ordering information

The SN74HC165 is an 8-bit parallel-load shift register that, when clocked, shift the data toward a serial (Q<sub>H</sub>) output. Parallel-in access to each stage is provided by eight individual direct data (A-H) inputs that are enabled by a low level at the shift/load (SH/LD) input. The SN74HC165 also features a clock-inhibit (CLK INH) function and a complementary serial  $(\overline{Q}_H)$  output.

Clocking is accomplished by a low-to-high transition of the clock (CLK) input while SH/LD is held high and CLK INH is held low. The functions of CLK and CLK INH are interchangeable. Since a low CLK and a low-to-high transition of CLK INH also accomplish clocking, CLK INH should be changed to the high level only while CLK is high. Parallel loading is inhibited when SH/LD is held high. While SH/LD is low, the parallel inputs to the register are enabled independently of the levels of the CLK, CLK INH, or serial (SER) inputs.

#### ORDERING INFORMATION<sup>†</sup>

TA	PACKAGE‡		ORDERABLE PART NUMBER	TOP-SIDE MARKING
4000 / 40500	SOIC - D	Tape and reel	SN74HC165QDRQ1	HC165Q1
-40°C to 125°C	TSSOP - PW	Tape and reel	SN74HC165QPWRQ1	HC165Q1

<sup>†</sup> For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



<sup>‡</sup> Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.

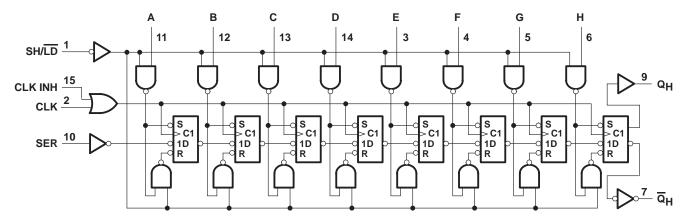
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#### **FUNCTION TABLE**

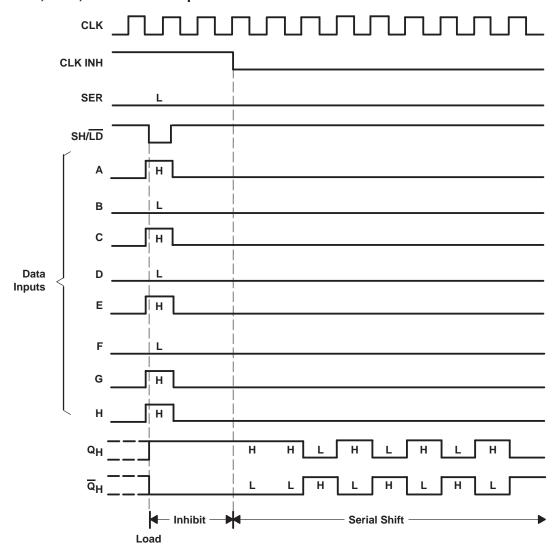
	INPUT	S	
SH/LD	CLK	CLK INH	FUNCTION
L	Χ	Х	Parallel load
Н	Н	Χ	No change
Н	Χ	Н	No change
Н	L	$\uparrow$	Shift <sup>†</sup>
Н	$\uparrow$	L	Shift <sup>†</sup>

<sup>†</sup>Shift = content of each internal register shifts toward serial output Q<sub>H</sub>. Data at SER is shifted into the first register.

## logic diagram (positive logic)



## typical shift, load, and inhibit sequence



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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	$\dots$ $-0.5\ V$ to 7 $V$
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{CC}$ ) (see Note 1)	±20 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{CC}$ ) (see Note 1)	±20 mA
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ )	±25 mA
Continuous current through V <sub>CC</sub> or GND	±50 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2): D package	73°C/W
PW package	108°C/W
Storage temperature range, T <sub>Sto</sub>	65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### recommended operating conditions (see Note 3)

			MIN	NOM	MAX	UNIT
Vcc	Supply voltage		2	5	6	V
		V <sub>CC</sub> = 2 V	1.5			
$\vee_{IH}$	High-level input voltage	$V_{CC} = 4.5 \text{ V}$	3.15			V
		V <sub>CC</sub> = 6 V	4.2			
		V <sub>CC</sub> = 2 V			0.5	
٧ <sub>IL</sub>	Low-level input voltage	$V_{CC} = 4.5 V$			1.35	V
		V <sub>CC</sub> = 6 V			1.8	
٧ <sub>I</sub>	Input voltage		0		VCC	V
٧o	Output voltage		0		VCC	V
		V <sub>CC</sub> = 2 V			1000	
$\Delta t/\Delta v^{\ddagger}$	Input transition rise/fall time	V <sub>CC</sub> = 4.5 V			500	ns
		V <sub>CC</sub> = 6 V			400	
TA	Operating free-air temperature		-40		125	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

<sup>‡</sup> If this device is used in the threshold region (from V<sub>IL</sub>max = 0.5 V to V<sub>IH</sub>min = 1.5 V), there is a potential to go into the wrong state from induced grounding, causing double clocking. Operating with the inputs at t<sub>t</sub> = 1000 ns and V<sub>CC</sub> = 2 V does not damage the device; however, functionally, the CLK inputs are not ensured while in the shift, count, or toggle operating modes.

## SN74HC165-Q1 8-BIT PARALLEL-LOAD SHIFT REGISTER

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## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

24244555	7507.001	DITIONS		Т	A = 25°C	;			
PARAMETER	TEST CON	DITIONS	VCC	MIN	TYP	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		
	VI = VIH or VIL	I <sub>OH</sub> = -20 μA	4.5 V	4.4	4.499		4.4		
Voн			6 V	5.9	5.999		5.9		V
		$I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.7		
		$I_{OH} = -5.2 \text{ mA}$	6 V	5.48	5.8		5.2		
			2 V		0.002	0.1		0.1	
		$I_{OL} = 20 \mu A$	4.5 V		0.001	0.1		0.1	
VoL	VI = VIH or VIL		6 V		0.001	0.1		0.1	V
		$I_{OL} = 4 \text{ mA}$	4.5 V		0.17	0.26		0.4	
		$I_{OL} = 5.2 \text{ mA}$	6 V		0.15	0.26		0.4	
lį	VI = VCC or 0		6 V		±0.1	±100		±1000	nA
Icc	$V_I = V_{CC}$ or 0,	IO = 0	6 V			8	_	160	μΑ
Ci		_	2 V to 6 V		3	10		10	pF

## SN74HC165-Q1 8-BIT PARALLEL-LOAD SHIFT REGISTER

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## timing requirements over recommended operating free-air temperature range (unless otherwise noted)

				T <sub>A</sub> =	25°C			
			VCC	MIN	MAX	MIN	MAX	UNIT
			2 V		6		4.2	
fclock	Clock frequency		4.5 V		31		21	MHz
			6 V		36		25	
			2 V	80		120		
		SH/LD low	4.5 V	16		24		
	Dule e duretie e			14		20		
t <sub>W</sub>	Pulse duration		2 V	80		120		ns
		CLK high or low	4.5 V	16		24		
			6 V	14		20		
			2 V	80		120		
		SH/LD high before CLK↑		16		24		
			6 V	14		20		.
			2 V	40		60		
		SER before CLK↑	4.5 V	8		12		
				7		10		
				100		150		
t <sub>su</sub>	Setup time	CLK INH low before CLK↑	4.5 V	20		30		ns
			6 V	17		25		
			2 V	40		60		
		CLK INH high before CLK↑	4.5 V	8		12		
			6 V	7		10		
			2 V	100		150		
		Data before SH/LD↓	4.5 V	20		30		
			6 V	17		26		
			2 V	5		5		
		SER data after CLK↑	4.5 V	5		5		
	Halden		6 V	5		5		
th	Hold time		2 V	5		5		ns
		PAR data after SH/LD↓	4.5 V	5		5		
			6 V	5		5		

## SN74HC165-Q1 8-BIT PARALLEL-LOAD SHIFT REGISTER

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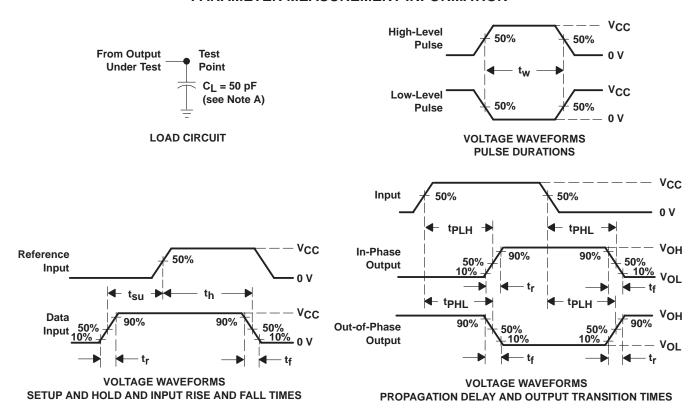
# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

	FROM	то	.,	T,	4 = 25°C	;			
PARAMETER	(INPUT)	(OUTPUT)	vcc	MIN	TYP	MAX	MIN	MAX	UNIT
			2 V	6	13		4.2		
f <sub>max</sub>			4.5 V	31	50		21		MHz
			6 V	36	62		25		
			2 V		80	150		225	
	SH/LD	$Q_H$ or $\overline{Q}_H$	4.5 V		20	30		45	ns
-			6 V		16	26		38	
	CLK		2 V		75	150		225	
<sup>t</sup> pd		Q <sub>H</sub> or $\overline{\mathbb{Q}}_{H}$	4.5 V		15	30		45	
·			6 V		13	26		38	
			2 V		75	150		225	
	Н	$Q_H$ or $\overline{Q}_H$	4.5 V		15	30		45	]
			6 V		13	26		38	
			2 V		38	75		110	
t <sub>t</sub>		Any	4.5 V		8	15		22	ns
			6 V		6	13		19	

## operating characteristics, $T_A = 25^{\circ}C$

		PARAMETER	TEST CONDITIONS	TYP	UNIT
ſ	C <sub>pd</sub>	Power dissipation capacitance	No load	75	pF

#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>I</sub> includes probe and test-fixture capacitance.

- B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \ \Omega$ ,  $t_f = 6 \ ns$ ,  $t_f = 6 \ ns$ .
- C. For clock inputs,  $f_{\text{max}}$  is measured when the input duty cycle is 50%.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
SN74HC165QDRQ1	Active	Production	SOIC (D)   16	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC165QQ1
SN74HC165QDRQ1.A	Active	Production	SOIC (D)   16	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC165QQ1
SN74HC165QDRQ1.B	Active	Production	SOIC (D)   16	2500   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC165QQ1
SN74HC165QPWRG4Q1	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC165Q1
SN74HC165QPWRG4Q1.A	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC165Q1
SN74HC165QPWRG4Q1.B	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC165Q1
SN74HC165QPWRQ1	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC165Q1
SN74HC165QPWRQ1.A	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC165Q1
SN74HC165QPWRQ1.B	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC165Q1

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

## PACKAGE OPTION ADDENDUM

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and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

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#### OTHER QUALIFIED VERSIONS OF SN74HC165-Q1:

Catalog : SN74HC165

● Enhanced Product: SN74HC165-EP

Military: SN54HC165

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications

## **PACKAGE MATERIALS INFORMATION**

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#### TAPE AND REEL INFORMATION





	-
A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74HC165QDRQ1	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74HC165QPWRG4Q1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74HC165QPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74HC165QDRQ1	SOIC	D	16	2500	353.0	353.0	32.0
SN74HC165QPWRG4Q1	TSSOP	PW	16	2000	353.0	353.0	32.0
SN74HC165QPWRQ1	TSSOP	PW	16	2000	353.0	353.0	32.0

## D (R-PDS0-G16)

### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.





SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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